# **Signetics**

# 8T26A, 28 Bus Transceivers

3-State Quad Bus Transceiver Product Specification

#### **Logic Products**

#### **FEATURES**

- High speed Schottky quad transceivers
- 48mA LOW-state drive
- 200µA bus loading
- Ideal for:
  - Half-duplex data transmission
  - Memory interface buffers
  - Data routing in bus oriented systems
  - High current drivers
  - MOS/CMOS-to-TTL interface

#### DESCRIPTION

The 8T26A/28 consists of four pairs of 3-state logic elements configured as quad bus drivers/receivers, along with separate buffered receiver enable and driver enable lines. This single IC quad transceiver design distinguishes the 8T26A/28 from conventional multi-IC implementations. In addition, the 8T26/28's ultra high speed while driving heavy bus capacitance (300pF) makes these devices particularly suitable for memory systems and bidirectional data buses.

Both the driver and receiver gates have 3-State outputs and low-current PNP

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
N8T26A	7ns	48mA
N8T28	10ns	67mA

#### **ORDERING CODE**

PACKAGES	COMMERCIAL RANGE V <sub>CC</sub> = 5V ±5%; T <sub>A</sub> = 0°C to +70°C
Plastic DIP	N8T26AN, N8T28N

#### NOTE:

For information regarding devices processed to Military Specifications, see the Signetics Military Products Data Manual.

#### INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

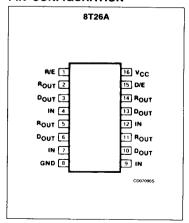
PINS	DESCRIPTION	N8T	S8T	
I <sub>N</sub>	Input	0.5Sul	0.5Sul	
D/E, R/E	Inputs	0.5Sul	0.5Sul	
D <sub>OUT</sub>	Output	24Sul	16Sul	
R <sub>OUT</sub>	Output	10Sul	6Sul	

#### NOTE:

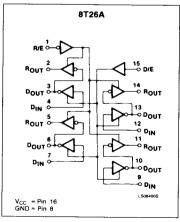
A unit load (Sul) is  $50\mu A l_{HH}$  and  $-2.0 mA l_{IL}$  inputs. 3-State outputs provide the high switching speeds of totem-pole TTL circuits while offering the bus capability of

open collector gates. PNP inputs reduce input loading to 200μA maximum.

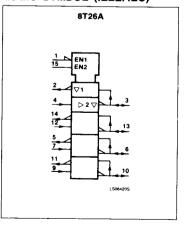
#### PIN CONFIGURATION



#### LOGIC SYMBOL



#### LOGIC SYMBOL (IEEE/IEC)



December 4, 1985

6-38

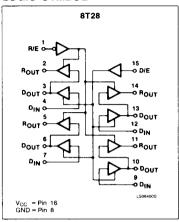
853-0163 77877/81495

# Bus Transceivers 8T26A, 28

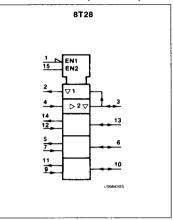
#### PIN CONFIGURATION

#### 8T28 R/E 🕥 16 VCC 15 D/E ROUT 2 14 ROUT POUT 3 IN 4 13 DOUT 12 IN ROUT 5 DOUT 6 TUOR III IN 2 10 a<sub>OUT</sub> 9 IN GND 8 C007090S

#### LOGIC SYMBOL



#### LOGIC SYMBOL (IEEE/IEC)



### ABSOLUTE MAXIMUM RATINGS (Over operating free-air temperature range unless otherwise noted.)

PARAMETER		S8T	N8T	UNIT	
Vcc	Supply voltage	7.0	7.0	٧	
V <sub>IN</sub>	Input voltage	-0.5 to +5.5	-0.5 to +5.5	` V	
I <sub>IN</sub>	Input current	-30 to +5	-30 to +5	mA	
l <sub>OL</sub>	Continuous	100	100	mA	
V <sub>OUT</sub>	Voltage applied to output in HIGH output state	-0.5 to +V <sub>CC</sub>	-0.5 to +V <sub>CC</sub>	٧	
TA	Operating free-air temperature range	-55 to +125	0 to 70	°C	

#### RECOMMENDED OPERATING CONDITIONS

PARAMETER			Min	Nom	Max	UNIT	
V <sub>CC</sub>	Supply voltage		4.75	5.0	5.25	V	
V <sub>IH</sub>	HIGH-level input voltage		2.0			٧	
VIL	LOW-level input voltage				+ 0.8	V	
l <sub>iK</sub>	Input clamp current				-18	mA	
Іон	HIGH-level output current	Driver			-10	mA	
loL		Driver			48	mA	
	LOW-level output current Receiver				20	mA	
T <sub>A</sub>	Operating free-air temperature	<u>'</u>	0		70	°C	

8T26A, 28

# DC ELECTRICAL CHARACTERISTICS (Over recommended operating free-air temperature range unless otherwise noted.)

	PARAMETER	TEST CONDITIONS <sup>1</sup>		N8T26A, N8T28		S8T26A, S8T28		TINU
				Min	Max	Min	Max	
VIH	Input HIGH voltage	Guaranteed input HIGH	threshold voltage	2.0		2.0		V
VIL	Input LOW voltage	Guaranteed input LOW	threshold voltage		0.8		0.8	v
$V_{iK}$	Input clamp diode voltage	V <sub>CC</sub> = MIN, I <sub>IK</sub> = -18mA	1		-1.2		-1.2	V
$V_{BD}$	Input breakdown voltage	V <sub>CC</sub> = MAX, I <sub>I</sub> = 1mA		5.5		5.5		V
Van	HIGH-level output voltage,	V - Adibi	I <sub>OH</sub> = -10mA	2.4			<b></b>	V
▼OH	VoH Driver outputs	V <sub>CC</sub> = MIN	I <sub>OH</sub> = -2mA			2.4		V
V <sub>OH</sub>	HIGH-level output voltage,	V <sub>CC</sub> = MIN, I <sub>OH</sub> = -100	μA	3.25				V
*OH	Receiver outputs	$V_{CC} = 5.0V$ , $I_{OH} = -100\mu A$				3.0		V
Voi	LOW-level output voltage,	V <sub>CC</sub> = MIN	I <sub>OL</sub> = 48mA		0.5			V
*OL	Driver outputs		I <sub>OL</sub> = 32mA				0.5	V
V <sub>OL</sub>	Vo. LOW-level output voltage,	V <sub>CC</sub> = MIN	I <sub>OL</sub> = 20mA		0.5			V
•OL	Receiver outputs	I <sub>OL</sub> = 12mA					0.5	V
l <sub>OZH</sub>	Off-state output current, HIGH-level voltage applied	$V_{CC} = MAX, V_O = 2.4V$			100		100	μА
I <sub>OZL</sub>	Off-state output current	$V_{CC} = MAX$ , $V_O = 0.5V$			-100		-100	μА
l <sub>H</sub>	HIGH-level input current	$V_{CC} = MAX, V_1 = 4.5V$			25		25	μΑ
IIL	LOW-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5V	Driver, receiver		-200		-200	μА
'IL			Disabled		-25		-25	μΑ
los	Short-circuit output current <sup>2</sup>	V <sub>CC</sub> = MAX	Driver	-50	-150	-50	-150	mA
OS	Short-direct output current		Receiver	-30	-100	-30	-100	mA
loo	Supply current	V - MAY	8T26A		87		87	mA
lcc	Supply Cullent	V <sub>CC</sub> = MAX	8T28		110	_	110	mA

#### NOTES:

# AC ELECTRICAL CHARACTERISTICS $T_A = 25$ °C, $V_{CC} = 5.0$ V

	PARAMETER	TEST CONDITIONS	8T26A		8T28		
	PARAMETER	TEST CONDITIONS	Min	Max	Min	Max	UNIT
t <sub>PHL</sub>	Propagation delay, D <sub>OUT</sub> to R <sub>OUT</sub>	C <sub>L</sub> = 30pF		14		17	ns
t <sub>PHL</sub>	Propagation delay, D <sub>IN</sub> to D <sub>OUT</sub>	C <sub>L</sub> = 300pF		14		17	ns
t <sub>PLH</sub>	Propagation delay, D <sub>OUT</sub> to R <sub>OUT</sub>	C <sub>L</sub> = 30pF		14		17	ns
t <sub>PLH</sub>	Propagation delay, D <sub>IN</sub> to D <sub>OUT</sub>	C <sub>L</sub> = 300pF		14		17	ns
t <sub>PZL</sub>	Data enable to data output, high Z to 0	C <sub>L</sub> = 300pF		25		28	ns
t <sub>PLZ</sub>	Data enable to data output, 0 to high Z	C <sub>L</sub> = 300pF	-	20		23	ns
t <sub>PZL</sub>	Reveive enable to receive output, high Z to 0	C <sub>L</sub> = 30pF		20		23	ns
t <sub>PLZ</sub>	Receive enable to receive output, 0 to high Z	C <sub>L</sub> = 30pF		15		18	ns

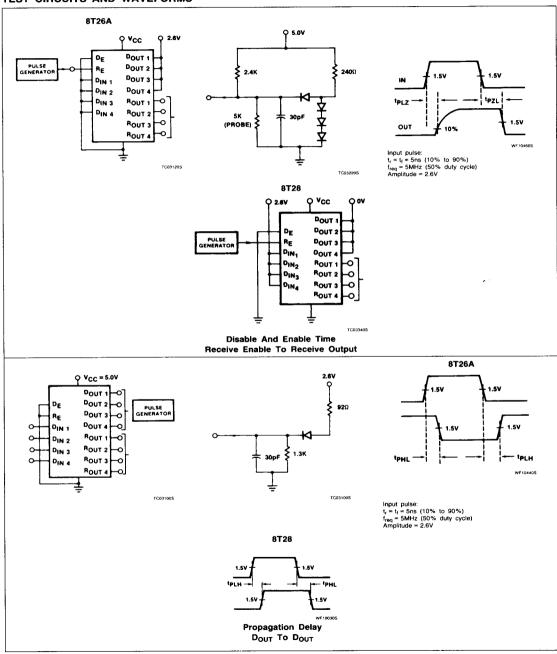
December 4, 1985

<sup>1.</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

Ios is tested with V<sub>OUT</sub> = +0.5V and V<sub>CC</sub> = V<sub>CC</sub> MAX +0.5V. Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

8T26A, 28

#### TEST CIRCUITS AND WAVEFORMS

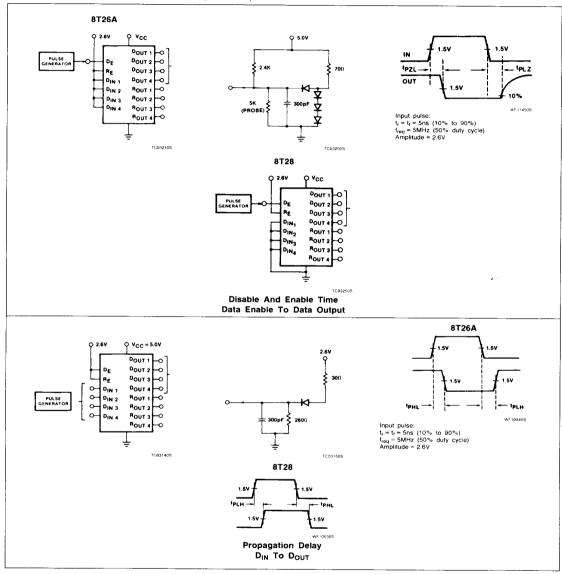


December 4, 1985

6-41

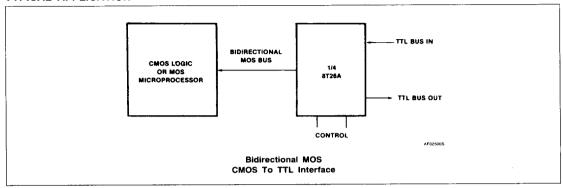
8T26A, 28

# TEST CIRCUITS AND WAVEFORMS (Continued)



8T26A, 28

#### TYPICAL APPLICATION



#### TYPICAL APPLICATION

